

Notice of References Cited	Application/Control No. 10/561,287		Applicant(s)/Patent Under Reexamination FEHRENBACHER, GEORG	
	Examiner Yara B. Green		Art Unit 2884	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,406,086	04-1995	Barthe et al.	250/390.03
*	B	US-5,321,269	06-1994	Kitaguchi et al.	250/370.05
*	C	US-5,656,815	08-1997	Justus et al.	250/337
*	D	US-6,654,435	11-2003	Kronenberg et al.	376/147
*	E	US-5,693,947	12-1997	Morton, Edward J.	250/370.09
*	F	US-5,572,027	11-1996	Tawil et al.	250/336.1
*	G	US-4,492,872	01-1985	Burgkhart et al.	250/484.3
*	H	US-6,566,657	05-2003	Odom et al.	250/390.11
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	McGregor, D.S. et al., "Design consideration for thin film coated semiconductor thermal neutron detectors-I: basics regarding alpha particle emitting neutron reactive films", Nuclear Instruments & Methods in Physics Research A, pgs. 272-308, Elsevier Science B.V., 2003
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.